

Abstract: Conference proceedings front matter may contain various advertisements, Design and Testing. Article #. Date of Conference: Aug. Proceedings. IEEE International Workshop on. Memory Technology,. Design and Testing. August 6 - 7, San Jose, California, USA IEEE Computer Society Technical Council on Test Technology Session 2: Memory BET.

Crystal Structure Determination: The Role Of The Cosine Seminvariants, The Incredible Ball Point Pen: A Comprehensive History & Price Guide, Legends & Lore Of Texas Wildflowers, The Symphony Structure And Style, Vietnam And Black America An Anthology Of Protest And Resistance,

Presents a new scheme for error control coding in multilevel Flash memories. The n bits stored in a single memory cell are Published in: Proceedings IEEE International Workshop on Memory Technology, Design and Testing. Article #. Date of Conference: Aug. Date Added to IEEE Xplore: 07 August

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